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- Inputs Are TTL-Voltage Compatible
- *EPIC* [™] (Enhanced-Performance Implanted CMOS) 1-μm Process
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), and Thin-Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK) and Flatpacks (W), and Standard Plastic (N) and Ceramic (J) DIPS

description

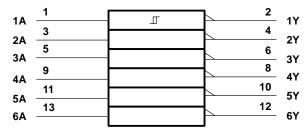
These Schmitt-trigger devices contain six independent inverters. They perform the Boolean function $Y = \overline{A}$. Because of the Schmitt action, they have different input threshold levels for positive-going (V_{T+}) and for negative-going (V_{T-}) signals.

These circuits are temperature compensated and can be triggered from the slowest of input ramps and still give clean, jitter-free output signals. They also have a greater noise margin than conventional inverters.

SN54ACT14 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ACT14 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each inverter)				
INPUT A	OUTPUT Y			
Н	L			
L	н			

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, DB, J, N, PW, or W packages.



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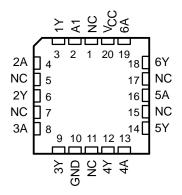
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SN54ACT14 J OR W PACKAGE
SN74ACT14 D, DB, N, OR PW PACKAGE
(TOP VIEW)

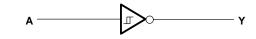
1A [1	\cup	14] ∨ _{cc}
1Y [13] V _{CC}] 6A
2A [3		12] 6Y
2Y [4		11	5A
3A [5		10] 5Y
	6] 4A
GND [7		8] 4Y

SN54ACT14 ... FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram, each inverter (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} Input voltage range, V_I (see Note 1) Output voltage range, V_O (see Note 1) Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) Continuous output current, I_O ($V_O = 0$ to V_{CC}) Continuous current through V_{CC} or GND Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2)	-0.5 V to V _{CC} + 0.5 V -0.5 V to V _{CC} + 0.5 V ±20 mA ±20 mA ±50 mA ±200 mA): D package
Storage temperature range, T _{stg}	PW package 0.5 W –65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero.

recommended operating conditions (see Note 3)

$\begin{tabular}{ c c c c c } \hline MIN & MAX & MIN \\ \hline V_{CC} & Supply voltage & 4.5 & 5.5 & 4.5 \\ \hline V_{IH} & High-level input voltage & 2.1 & 2.1 \\ \hline V_{IL} & Low-level input voltage & 0 & 0 & 0 \\ \hline V_{I} & Input voltage & 0 & V_{CC} & 0 \\ \hline V_{O} & Output voltage & 0 & V_{CC} & 0 \\ \hline \end{array}$	MAX 5.5	
VIH High-level input voltage 2.1 2.1 VIL Low-level input voltage 0.5 0 VI Input voltage 0 VCC 0 VO Output voltage 0 VCC 0	5.5	V
VIL Low-level input voltage 0.5 VI Input voltage 0 VCC 0 VO Output voltage 0 VCC 0		
VI Input voltage 0 V _{CC} 0 V _O Output voltage 0 V _{CC} 0		V
Vo Output voltage 0 VCC 0	0.5	V
	VCC	V
	VCC	V
IOH High-level output current24	-24	mA
I _{OL} Low-level output current 24	24	mA
$\Delta t/\Delta v$ Input transition rise or fall rate $\begin{pmatrix} \sim & 0 & 8 \\ 0 & 0 & 0 \end{pmatrix}$	8	ns/V
T _A Operating free-air temperature -55 125 -40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.



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PARAMETER	TEST CONDITIONS	N.	T _A = 25°C		SN54ACT14		4 SN74ACT14		UNIT		
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
V _{T+}		4.5 V	1.2	1.5	1.9	1.2	1.9	1.2	1.9	V	
Positive-going threshold		5.5 V	1.4	1.7	2.1	1.4	2.1	1.4	2.1	v	
V _T -		4.5 V	0.5	0.9	1.2	0.5	1.2	0.5	1.2	V	
Negative-going threshold		5.5 V	0.6	1	1.4	0.6	1.4	0.6	1.4	v	
ΔV_T		4.5 V	0.4	0.6	1.4	0.4	1.4	0.4	1.4	V	
Hysteresis (V _{T+} – V _{T–})		5.5 V	0.4	0.6	1.5	0.4	1.5	0.4	1.5	v	
	10	4.5 V	4.4	4.49		4.4		4.4			
	l _{OH} = –50 μA	5.5 V	5.4	5.49		5.4	:W	5.4		v	
VOH	1 04 mA	4.5 V	3.86			3.7	:W	3.76			
	I _{OH} = -24 mA	5.5 V	4.86			4.7	<i>Q</i> ²	4.76			
	$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V				3.85					
	I _{OH} = -75 mA [†]	5.5 V				na		3.85		1	
	L 50 A	4.5 V		0.001	0.1	b B	0.1		0.1		
	I _{OL} = 50 μA	5.5 V		0.001	0.1	A	0.1		0.1		
N		4.5 V			0.36		0.5		0.44	v	
VOL	I _{OL} = 24 mA	5.5 V			0.36		0.5		0.44		
	I _{OL} = 50 mA [†]	5.5 V					1.65				
	I _{OL} = 75 mA [†]	5.5 V							1.65		
lj	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1		±1	μA	
ICC	$V_{I} = V_{CC} \text{ or GND}, I_{O} = 0$	5.5 V			2		40		20	μA	
ΔI_{CC}^{\ddagger}	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V			0.6		1.6		1.5	mA	
Ci	$V_{I} = V_{CC} \text{ or } GND$	5 V		4.5						pF	

electrical	characteristics	over	recommended	operating	free-air	temperature	range	(unless
otherwise	noted)					-	•	•

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

[‡] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

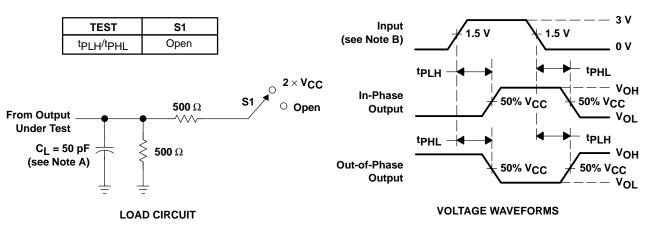
PARAMETER	FROM	то	T _A = 2	25°C	SN54ACT14	SN74A	CT14	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN MAX	MIN	MAX	
^t PLH	٨	V	1.5	11.5	9 14	1	12.5	
^t PHL	A	T	1.5	10	1 13	1	11	ns

operating characteristics, V_CC = 5 V, T_A = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	$C_L = 50 \text{ pF}, \text{ f} = 1 \text{ MHz}$	20	pF



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_Q = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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